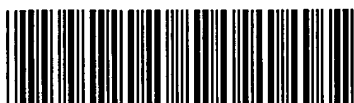


Search Notes

Application/Control No.

10/530,266

Examiner

Raymond Phan

Applicant(s)/Patent under
Reexamination

RADULESCU ET AL.

Art Unit

2111

SEARCHED

Class	Subclass	Date	Examiner
710	305-317, 36-38	6/15/2006	RP
719	313	6/16/2006	RP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR